

<b>Notice of References Cited</b>	Application/Control No. 10/556,245		Applicant(s)/Patent Under Reexamination HENDRIKS ET AL.	
	Examiner THANH T. NGUYEN		Art Unit 2813	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0136927	09-2002	Hieda et al.	428/694.00T
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*	C	US-6,309,726	10-2001	Ono et al.	428/64.1
*	D	US-2002/0039346	04-2002	Abe et al.	369/275.4
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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